


<b>Search Notes</b>  	<b>Application/Control No.</b>  10518824	<b>Applicant(s)/Patent Under Reexamination</b>  BAEY ET AL.
	<b>Examiner</b>  ANDREW LAI	<b>Art Unit</b>  2616

SEARCHED			
Class	Subclass	Date	Examiner
370	318	3/11/08	AL
455	127.1	3/11/08	AL

SEARCH NOTES		
Search Notes	Date	Examiner
conducted text search using EAST DB	3/11/08	AL
Discussion with SPE Kwang Yao on claim interpretation and final rejection	3/10/08	AL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner